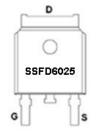
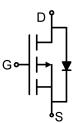


Main Product Characteristics:

| V _{DSS} | -60V | | | | |
|----------------------|-------------|--|--|--|--|
| R _{DS} (on) | 12mΩ (typ.) | | | | |
| I _D | -60A | | | | |







TO-252

Marking and pin Schematic Diagram
Assignments

Features and Benefits:

- Advanced trench MOSFET process technology
- Special designed for PWM, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- High Power and current handing capability
- Fully Avalanche Rated



Description:

It utilizes the advanced trench processing techniques to achieve extremely low on resistance and low gate charge. These features combine to make this design an extremely efficient and reliable device for use in PWM, load switching and a wide variety of other applications.

Absolute Max Rating:

| Symbol | Parameter | Max. | Units |
|---|--|--------------|-------|
| I _D @ T _C = 25°C | Continuous Drain Current, V _{GS} @ 10V① | -60 | |
| I _D @ T _C = 100°C | Continuous Drain Current, V _{GS} @ 10V① | -50 | Α |
| I _{DM} | Pulsed Drain Current② | -240 | A |
| I _{SM} | Pulsed Source Current (Body Diode)2 | -240 | |
| P _D @T _C = 25°C | Power Dissipation ³ | 166 | W |
| V _{DS} | Drain-Source Voltage | -60 | V |
| V _{GS} | Gate-to-Source Voltage | ± 20 | V |
| Eas | Single Pulse Avalanche Energy @ L=0.3mH | 300 | mJ |
| I _{AS} | Single Pulse Avalanche Current @ L=0.3mH | 44 | Α |
| TJ | Operating Junction and | 55 to 1.450 | 0.0 |
| T _{STG} | Storage Temperature Range | -55 to + 150 | °C |



Thermal Resistance

| Symbol | Characterizes | Value | Unit |
|------------------|--|-------|------|
| R _{θJA} | Junction-to-ambient (t \leq 10s) (4) | 62 | °C/W |
| Rejc | Maximum Junction-to-Case③ | 0.75 | °C/W |

Electrical Characteristics @T_A=25 ℃ unless otherwise specified

| Symbol | Parameter | Min. | Тур. | Max. | Units | Conditions |
|---------------------|--------------------------------------|------|------|------|-------|---|
| BV _{DSS} | Drain-to-Source breakdown voltage | -60 | _ | _ | V | V _{GS} = 0V, I _D =- 250μA |
| R _{DS(on)} | Static Drain-to-Source on-resistance | _ | 12 | 25 | mΩ | V _{GS} =-10V, I _D =- 23A |
| V _{GS(th)} | Gate threshold voltage | -1 | | -3 | V | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$ |
| I _{DSS} | Drain-to-Source leakage current | _ | _ | -1 | μA | V _{DS} =-60V,V _{GS} = 0V |
| | Gate-to-Source forward leakage | _ | _ | 100 | | V _{GS} =20V |
| I _{GSS} | Gate-to-Source reverse leakage | _ | _ | -100 | nA | V _{GS} = -20V |
| Qg | Total gate charge | _ | _ | 170 | | I _D =-30A, |
| Qgs | Gate-to-Source charge | _ | _ | 30 | nC | V _{DD} =-40V, |
| Qgd | Gate-to-Drain("Miller") charge | _ | _ | 70 | | V _{GS} =-10V |
| td(on) | Turn-on delay time | _ | 15.2 | _ | | V 20V/1 20A |
| tr | Rise time | _ | 23.7 | _ | no | V _{DD} =-30V,I _D =-20A, |
| td(off) | Turn-Off delay time | _ | 53.3 | _ | ns | $R_L=1.50\Omega, R_G=3.00\Omega,$ |
| tf | Fall time | _ | 12.7 | _ | | V _{GS} =-10V |
| Ciss | Input capacitance | _ | 7456 | _ | | V _{DS} =-25V, |
| Coss | Output capacitance | _ | 376 | _ | pF | V _{GS} =0V, |
| Crss | Reverse transfer capacitance | _ | 293 | _ | | f=1MHZ |

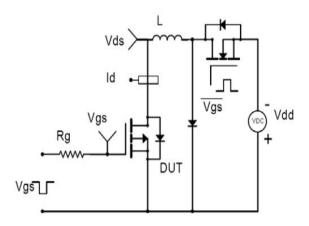
Source-Drain Ratings and Characteristics

| Symbol | Parameter | Min. | Тур. | Max. | Units | Conditions |
|-----------------|--------------------------|------|-------|------|-------|---|
| 1. | Maximum Body-Diode | | 60 | | ^ | MOSFET symbol □ □ |
| Is | Continuous Current | _ | -60 | _ | Α | showing the G⊷ H ¥ |
| lau | Maximum Body-Diode Pulse | | -240 | | Α | integral reverse |
| lsм | Current | | -240 | | Α | p-n junction diode. |
| V _{SD} | Diode Forward Voltage | _ | -0.74 | -1.2 | V | T _J =25°C,I _S =-10A,V _{GS} =0V |
| t _{rr} | Reverse Recovery Time | _ | 38.2 | _ | nS | T _J = 25°C, I _F =-20A, di/dt = |
| Q _{rr} | Reverse Recovery Charge | _ | 62.5 | _ | nC | 100A/μs |

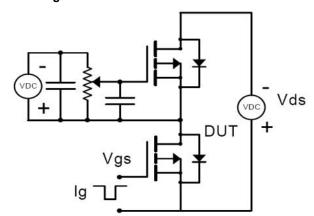


Test Circuits and Waveforms

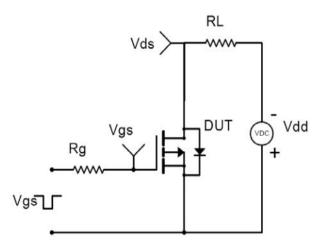
EAS Test Circuit:



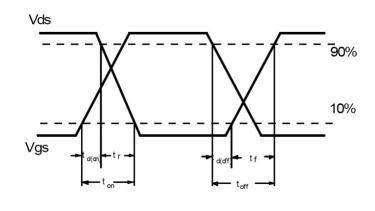
Gate Charge Test Circuit:



Switching Time Test Circuit:



Switching Waveforms:



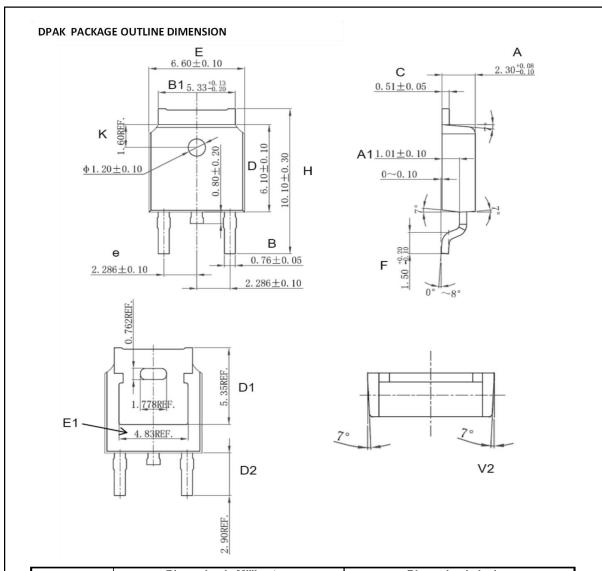
Version: 1.1

Notes:

- ①Calculated continuous current based on maximum allowable junction temperature.
- ②Repetitive rating; pulse width limited by max. junction temperature.
- $\ \ \,$ The power dissipation P_D is based on max. junction temperature, using junction-to-case thermal resistance.
- 4 The value of $R_{\theta JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with T_A =25°C



Mechanical Data:



| Cumbal | Dim | ension In Millim | eters | Dimension In Inches | | | | |
|--------|-------|------------------|--------|---------------------|-------------|-------|--|--|
| Symbol | Min | Nom | Max | Min | Nom | Max | | |
| Α | 2.200 | 2.300 | 2.380 | 0.087 | 0.091 | 0.094 | | |
| A1 | 0.910 | 1.010 | 1.110 | 0.036 | 0.040 | 0.044 | | |
| В | 0.710 | 0.760 | 0.810 | 0.028 | 0.030 | 0.032 | | |
| B1 | 5.130 | 5.330 | 5.460 | 0.202 | 0.210 | 0.215 | | |
| С | 0.460 | 0.510 | 0.560 | 0.018 | 0.020 | 0.022 | | |
| D | 6.000 | 6.100 | 6.200 | 0.236 | 0.240 | 0.244 | | |
| D1 | | 5.350 (REF) | | 0.211 (REF) | | | | |
| D2 | | 2.900 (REF) | | | 0.114 (REF) | | | |
| E | 6.500 | 6.600 | 6.700 | 0.256 | 0.260 | 0.264 | | |
| E1 | | 4.83 (REF) | | | 0.190 (REF) | | | |
| е | 2.186 | 2.286 | 2.386 | 0.086 | 0.090 | 0.094 | | |
| Н | 9.800 | 10.100 | 10.400 | 0.386 | 0.398 | 0.409 | | |
| F | 1.400 | 1.500 | 1.700 | 0.055 | 0.059 | 0.067 | | |
| K | | 1.600 (REF) | | 0.063 (REF) | | | | |
| V2 | | 8° (REF) | | | 8° (REF) | | | |





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